

A Model Based Method for Tomographic Reconstructions of Nanoparticle Assemblies

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Small angle X-ray scattering is a primary tool for resolving the crystal structures of self-assembled nanoparticle superlattices [1]. However, it is not quite informative when periodic lattices are broken into clusters due to their inhomogeneity. Therefore, it is desirable to develop a method to rapidly reconstruct the three-dimensional architecture of cluster ensembles in real space. Conventional tilt-series electron tomography is well poised for this task; it is, yet, limited by its low throughput. For instance, a reasonable reconstruction generally requires 70-140 tilt images, which would need 40 minutes or 2-4 hours to record a BF-TEM or an ADF-STEM tilt series, respectively. In addition, the intensity of BF-TEM images is not a linear or any simple monotonic function of the sample thickness particularly when gold nanoparticles are imaged; this could dramatically lower the resolution and interpretability of the reconstructed tomograms. Here, we present a model based tomographic method that only relies on the projected centroids of the nanoparticles and bypasses the image intensity. This method only requires 5-10 tilt images and it is useful for calibrating a TEM goniometer and field/scan distortions.

This method is based on measuring the geometric centers $(x^i(\theta), y^i(\theta))$ of nanoparticles in the projected images as a function of the tilt angle θ , where the superscript i is the label for each individual particle. The frame of reference/rotation axis can be shifted to a specific particle n by a pre-subtraction procedure, i.e., $(x^i(\theta), y^i(\theta)) = (x^i(\theta), y^i(\theta)) - (x^n(\theta), y^n(\theta))$. The three-dimensional (3-D) positions of the particles at zero degree tilt in the particle n reference frame can be retrieved by a nonlinear least squares fitting of the below equation.

$$\begin{pmatrix} x^i(\theta) \\ y^i(\theta) \\ z^i(\theta) \end{pmatrix} = \begin{pmatrix} \cos \alpha & -\sin \alpha & 0 \\ \sin \alpha & \cos \alpha & 0 \\ 0 & 0 & 1 \end{pmatrix} \begin{pmatrix} \cos \beta & 0 & \sin \beta \\ 0 & 1 & 0 \\ -\sin \beta & 0 & \cos \beta \end{pmatrix} \begin{pmatrix} 1 & 0 & 0 \\ 0 & \cos \theta & -\sin \theta \\ 0 & \sin \theta & \cos \theta \end{pmatrix} \begin{pmatrix} x_0^i \\ y_0^i \\ z_0^i \end{pmatrix} \quad (1)$$

where, α is the image/scan rotation with respect to the projected tilt axis, and β is the offset angle between the 3-D tilt axis and the projection plane (Fig. 1a). There are five unknowns— α , β , (x_0^i, y_0^i, z_0^i) —in the above equation. At each tilt, two linearly independent equations can be provided— $(x^i(\theta), y^i(\theta))$ are observables. Therefore, in principal, only three tilt images are needed to solve all the unknowns; in practice, however, a couple of tilt images are needed to average out drift and scan distortions.

Fig. 1 shows the measured and modeled trajectories of gold nanoparticles supported on a carbon grid. The actual 3-D tilt-axis has a 1.5 degree take-off angle from the projection plane as evidenced by the $(x^i(\theta), y^i(\theta))$ plot in Fig. 1b. Using the model based fitting method, particles positions and their rotational trajectory can be reconstructed (Fig. 1c). This method can be further applied to a hetero-particle system (Fig. 2). Using prior knowledge of the system—i.e. the center particle of the cluster is cubic—a model based reconstruction of the seven-particle cluster can achieved (Fig. 2c).

References

[1] Y. Zhang, F. Lu, *et al*, Nature Nanotechnology, **8**, 865 (2013)
 [2] Research was carried out at the Center for Functional Nanomaterials, Brookhaven National Laboratory, which is supported by the U.S. Department of Energy, Office of Basic Energy Sciences, under Contract No. DE-AC02-98CH10886.

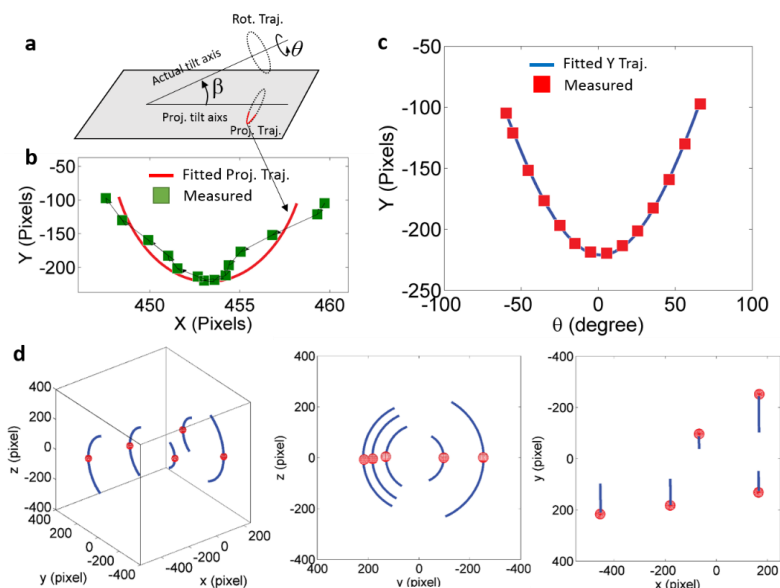


Fig. 1. Model based fitting of the 3-D particle positions using Eq. (1). (a) A schematic plot showing the geometry of the actual tilt axis and the projected tilt axis. (b) Measured and modeled projected trajectory of a particle from -60 degrees to +66 degrees. The offset angle between the tilt axis and the projection plane is determined to be 1.5 degrees. (c) The projected Y movement of the particle overlaid with the fitted model. (d) Reconstructed 3-D positions of five nanoparticles.

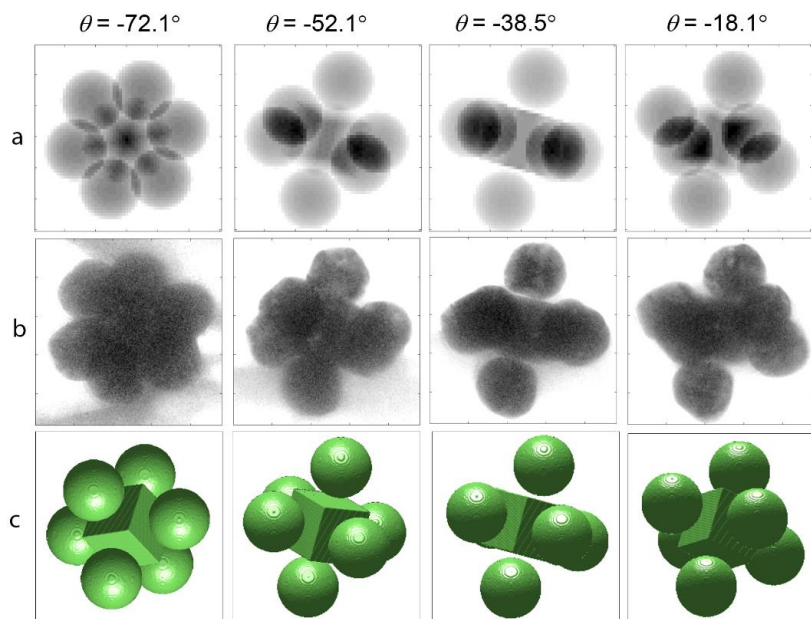


Fig. 2. A model based reconstruction of a hetero-particle cluster. (a) The modeled projection images at specified tilt angles. (b) BF-TEM images recorded in a 120 keV TEM. (c) The isosurface rendering of the reconstruction at the specified tilt angles.